Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10582090	IMAI, KAZUHIRO
Examiner	Art Unit
Leon Y Lum	1641

SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES				
Search Notes	Date	Examiner		
Inventor search in eDAN, PALM and STN (search history attached). Search included copending and patented claims for double patenting analysis.	1/14/09	LYL		
EAST search using keywords (search history attached).	1/14/09	LYL		
STIC search on structures of claims 13 and 14	3/12/09	LYL		
STIC search on structures of claims 21 and 22	3/18/09	LL		
Discussed the prior art, including STIC search, and claims 21 and 22 with Mark Shibuya and Nelson Yang, who suggested broadening the search.	3/20/09	LYL		
STN search using keywords (search history attached).	3/24/09	LYL		
Discuss STIC search on 3/18/09 and claims 21 and 22 with Shafiqul Haq, who suggested broadening the search.	3/25/09	LYL		
Refined STIC search.	3/25/09	LYL		
Updated search.	1/11/10	LYL		

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	

/Leon Y Lum/ Examiner.Art Unit 1641	

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